

Notice of References Cited	Application/Control No. 10/562,375		Applicant(s)/Patent Under Reexamination NEBEL ET AL.	
	Examiner ALLEN CHAN		Art Unit 4116	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,176,780 B1	01-2001	Miyamoto et al.	463/4
*	B	US-6,279,906 B1	08-2001	Sanderson et al.	273/148B
*	C	US-5,436,640	07-1995	Reeves, David W.	345/161
*	D	US-5,807,175	09-1998	Davis et al.	463/36
*	E	US-2002/0082064 A1	06-2002	Hillman, Mark Lee	463/4
*	F	US-4,575,086	03-1986	Kim et al.	74/417
*	G	US-2002/0125633 A1	09-2002	Mashkabov, Rakhmin	273/108.1
*	H	US-5,643,087	07-1997	Marcus et al.	463/38
*	I	US-6,271,828 B1	08-2001	Rosenberg et al.	345/156
*	J	US-6,484,942 B1	11-2002	Yokoyama et al.	235/462.03
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.